HEXFET® Power MOSFET

Orderable Part Number

IRFIZ44NPbF

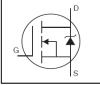


- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS (\$)
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated

Base Part Number

IRFIZ44NPbF

Lead-Free



$V_{ exttt{DSS}}$	55V
R _{DS(on)}	0.024Ω
l _n	31A

Standard Pack

Quantity

50

Transfer of the state of the st
TO-220 Full-Pak

G	D	S
Gate	Drain	Source

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low onresistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 Full Pak eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heat sink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heat sink using a single clip or by a single screw fixing.

Package Type

TO-220 Full-Pak

Absolute Maximu Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	31	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	22	A
DM	Pulsed Drain Current ① ⑥	160	
P _D @T _C = 25°C	Maximum Power Dissipation	45	W
	Linear Derating Factor	0.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
= AS	Single Pulse Avalanche Energy (Thermally Limited) ②⑥	210	mJ
AR	Avalanche Current ①⑥	25	Α
= AR	Repetitive Avalanche Energy ①	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt③⑥	5.0	V/ns
Γ _J	Operating Junction and	-55 to + 175	
$\Gamma_{ m STG}$	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Form

Tube

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		3.3	°C/W
$R_{\theta JA}$	Junction-to-Ambient		65	C/VV

2017-04-27



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$	
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.055		V/°C	Reference to 25°C, I _D = 1mA ®	
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.024	Ω	V _{GS} = 10V, I _D = 17A	
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
gfs	Forward Trans conductance	17			S	V _{DS} = 25V, I _D = 25A [®]	
1	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 55V, V_{GS} = 0V$	
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 150^{\circ}C$	
1	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$	
I _{GSS}	Gate-to-Source Reverse Leakage			-100	11/	$V_{GS} = -20V$	
Q_g	Total Gate Charge			65		I _D = 25A	
Q_{gs}	Gate-to-Source Charge			12	nC	$V_{DS} = 44V$	
Q_{qd}	Gate-to-Drain Charge			27		V _{GS} = 10V , See Fig. 6 and 13④@	
$t_{d(on)}$	Turn-On Delay Time		7.3			$V_{DD} = 28V$	
t _r	Rise Time		69		no	I _D =25A	
$t_{d(off)}$	Turn-Off Delay Time		47		ns	$R_G = 12\Omega$	
t _f	Fall Time		60			R _D = 1.1Ω, See Fig. 10⊕6	
L_D	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.)	
Ls	Internal Source Inductance		7.5		1111	from package and center of die contact	
C _{iss}	Input Capacitance		1300			$V_{GS} = 0V$	
C _{oss}	Output Capacitance		410		ے ا	V _{DS} = 25V	
C _{rss}	Reverse Transfer Capacitance		150		pF	f = 1.0MHz, See Fig. 56	
С	Drain to Sink Capacitance		12			f = 1.0MHz	
Source-Drain	Ratings and Characteristics						
	Parameter	Min.	Тур.	Max.	Units	Conditions	
	Continuous Source Current			0.4		MOSFET symbol	

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			31	_	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			160		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 17A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		65	98	ns	$T_J = 25^{\circ}C, I_F = 25A$
Q _{rr}	Reverse Recovery Charge		160	240	μС	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsio	turn-on	time is	negligib	le (turn-on is dominated by L _S +L _D)

Notes:

- ② starting $T_J = 25$ °C, $L = 470\mu H$, $R_G = 25\Omega$, $I_{AS} = 25A$ (See fig. 12)
- $\label{eq:local_local_local} \mbox{\Im} \quad I_{SD} \leq 25 \mbox{A, di/dt} \leq 320 \mbox{A/} \mu \mbox{s, } V_{DD} \leq V_{(BR)DSS}, \ T_{J} \leq 175 \mbox{$^{\circ}$C}.$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ t=60s, *f*=60Hz
- 6 Uses IRFZ44N data and test conditions.

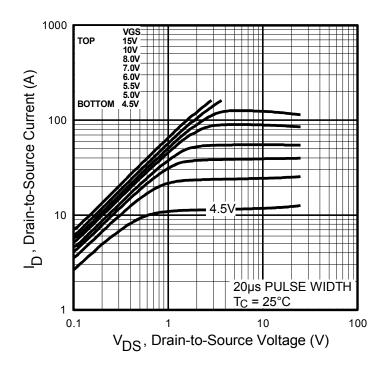


Fig. 1 Typical Output Characteristics

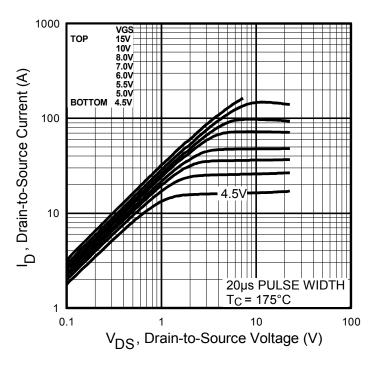


Fig. 2 Typical Output Characteristics

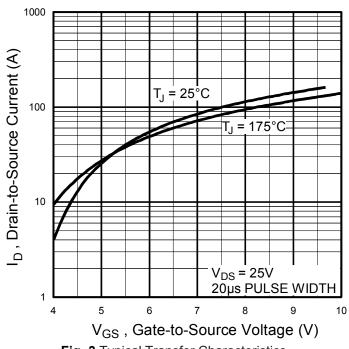


Fig. 3 Typical Transfer Characteristics

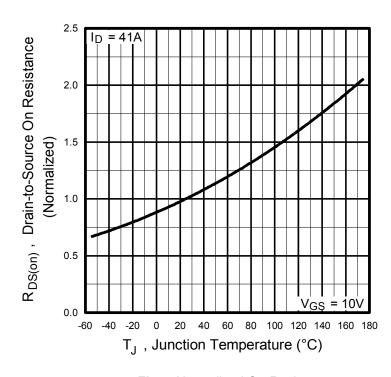


Fig. 4 Normalized On-Resistance vs. Temperature



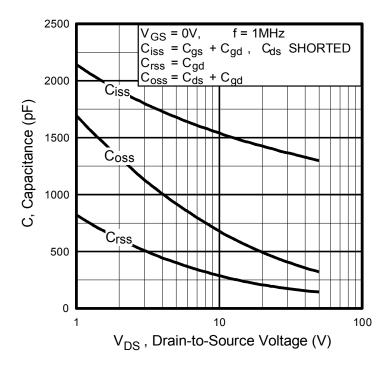


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

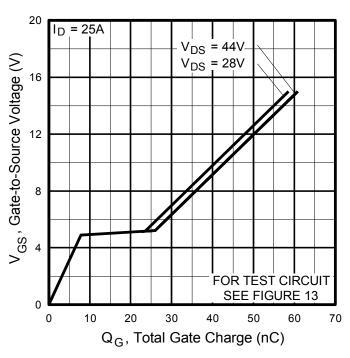


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

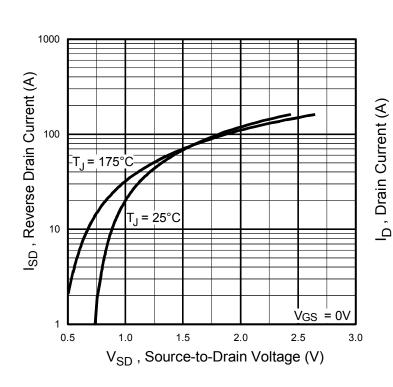


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

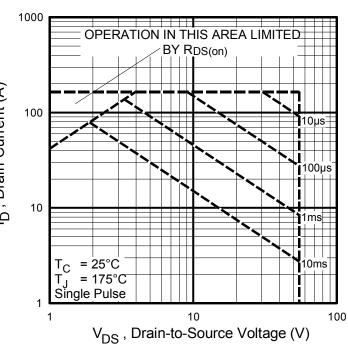


Fig 8. Maximum Safe Operating Area

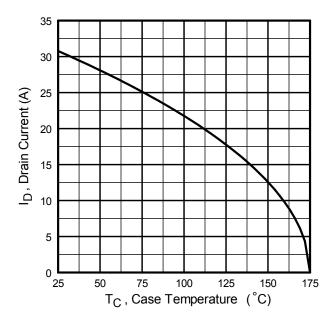


Fig 9. Maximum Drain Current vs. Case Temperature

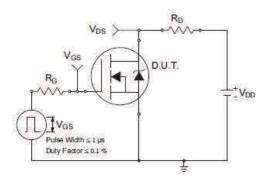


Fig 10a. Switching Time Test Circuit

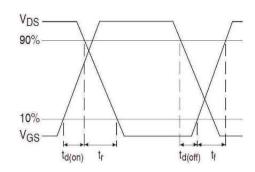


Fig 10b. Switching Time Waveforms

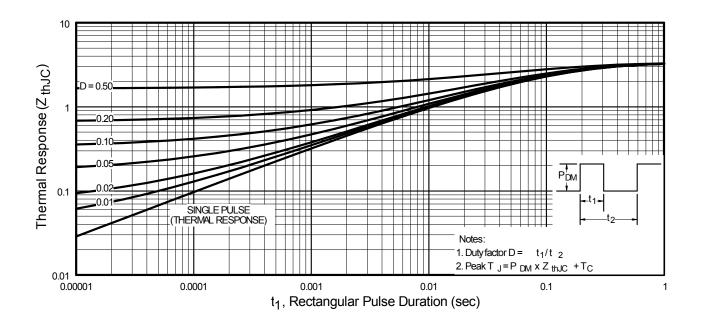


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



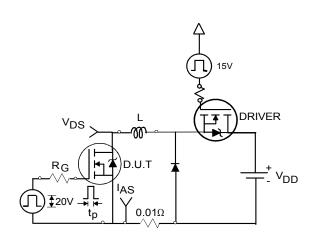


Fig 12a. Unclamped Inductive Test Circuit

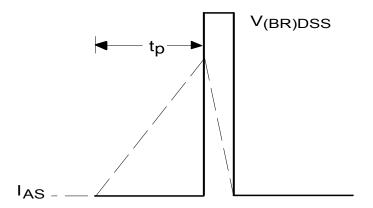


Fig 12b. Unclamped Inductive Waveforms

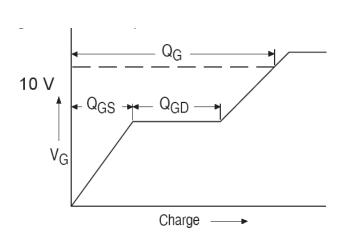


Fig 13a. Gate Charge Waveform

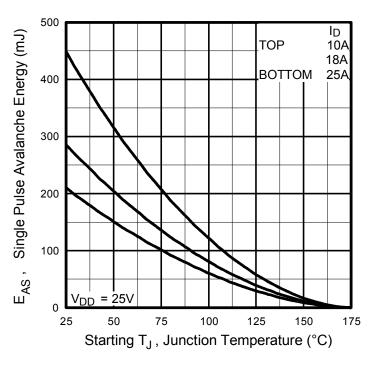


Fig 12c. Maximum Avalanche Energy vs. Drain Current

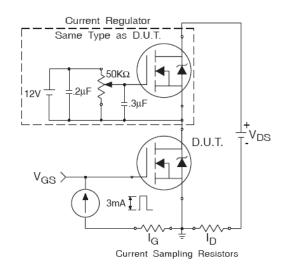
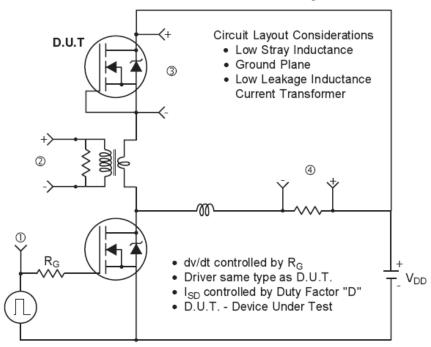


Fig 13b. Gate Charge Test Circuit

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Peak Diode Recovery dv/dt Test Circuit



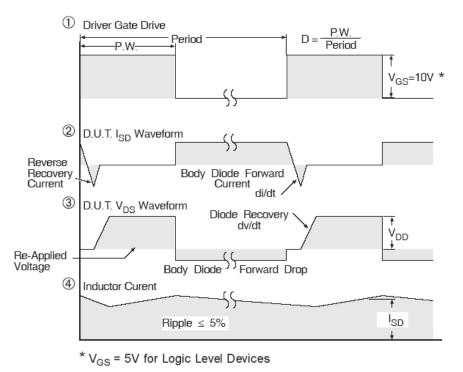
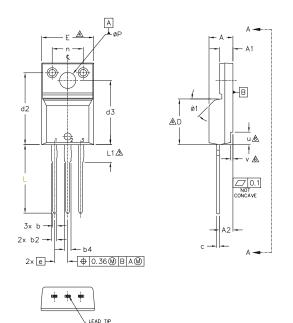
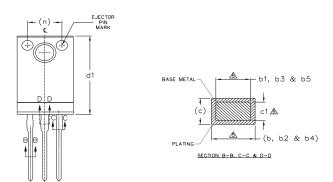


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

- 1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- 2,0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- (1) LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.

- 5,0 DIMENSION 61, 63, 65 & c1 APPLY TO BASE METAL ONLY.
- 6.0 STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
- 7.0 CONTROLLING DIMENSION: INCHES.

S Y M	DIMENSIONS				N
В	MILLIM	ETERS	INC	HES	O T E S
O L	MIN.	MAX.	MIN.	MAX.	S S
Α	4.57	4.83	.180	.190	
Α1	2.57	2.82	.101	.111	
A2	2.51	2.92	.099	.115	
b	0.61	0.94	.024	.037	
ь1	0.61	0.89	.024	.035	5
b2	0.76	1.27	.030	.050	
ь3	0.76	1.22	.030	.048	5
Ь4	1.02	1.52	.040	.060	
ь5	1.02	1.47	.040	.058	5
С	0.33	0.63	.013	.025	
с1	0.33	0.58	.013	.023	5
D	8.66	9.80	.341	.386	4
d1	15.80	16.13	.622	.635	
d2	13.97	14.22	.550	.560	
d3	12.29	12.93	.484	.509	
Ε	9.63	10.74	.379	.423	4
е		BSC	.100	BSC	
L	13.21	13.72	.520	.540	
L1	3.10	3.68	.122	.145	3
n	6.05	6.60	.238	.260	
øΡ	3.05	3.45	.120	.136	
u	2.39	2.49	.094	.098	6
V	0.41	0.51	.016	.020	6
Ø1	_	45°	_	45°	

LEAD ASSIGNMENTS

<u>HEXFET</u>

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE

IGBTs, CoPACK

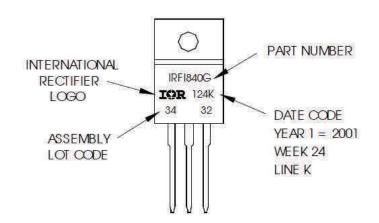
- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER

TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G WITH ASSEMBLY LOT CODE 3432

ASSEMBLED ON WW 24, 2001 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to website at http://www.irf.com/package/



Qualification Information

Qualification Level	Industrial (per JEDEC JESD47F) [†]			
Moisture Sensitivity Level	TO-220 Full-Pak N/A			
RoHS Compliant	Yes			

† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comments		
	Changed datasheet with Infineon logo - all pages.		
04/27/2017	Corrected Package Outline on page 8.		
	Added disclaimer on last page.		

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